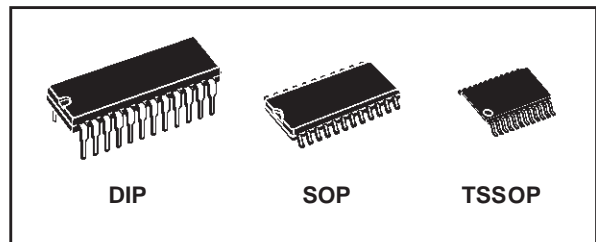




M74HCT646

OCTAL BUS TRANSCEIVER/REGISTER WITH 3 STATE OUTPUTS

- HIGH SPEED:
 $f_{MAX} = 60 \text{ MHz (TYP.) at } V_{CC} = 4.5V$
- LOW POWER DISSIPATION:
 $I_{CC} = 4\mu A(\text{MAX.}) \text{ at } T_A=25^\circ C$
- COMPATIBLE WITH TTL OUTPUTS :
 $V_{IH} = 2V \text{ (MIN.) } V_{IL} = 0.8V \text{ (MAX)}$
- SYMMETRICAL OUTPUT IMPEDANCE:
 $|I_{OH}| = I_{OL} = 6mA \text{ (MIN)}$
- BALANCED PROPAGATION DELAYS:
 $t_{PLH} \approx t_{PHL}$
- PIN AND FUNCTION COMPATIBLE WITH
 74 SERIES 646



ORDER CODES

PACKAGE	TUBE	T & R
DIP	M74HCT646B1R	
SOP	M74HCT646M1R	M74HCT646RM13TR
TSSOP		M74HCT646TTR

DESCRIPTION

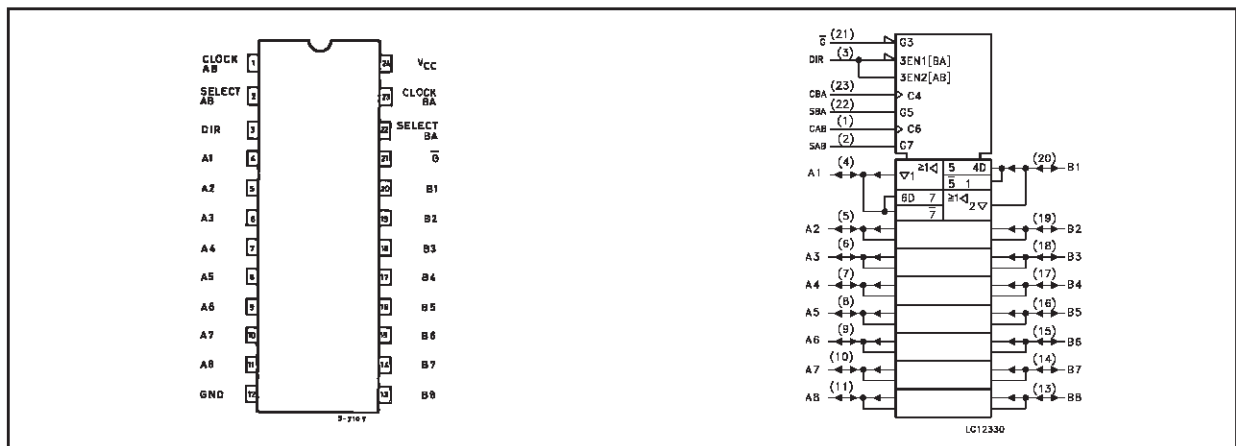
The 74HCT646 is an advanced high-speed CMOS OCTAL BUS TRANSCEIVER AND REGISTER (3-STATE) fabricated with silicon gate C²MOS technology.

This device consists of bus transceiver circuits with 3 state, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the input bus or from the internal registers. Data on the A or B bus will be clocked into register on the low to high transition of the appropriate clock pin (Clock AB or Clock BA). Enable (\overline{G}) and direction (DIR) pins are provided to control the transceiver functions. In the transceiver mode, data present at the high-impedance port may be stored in either register or in both. The select controls (Select AB

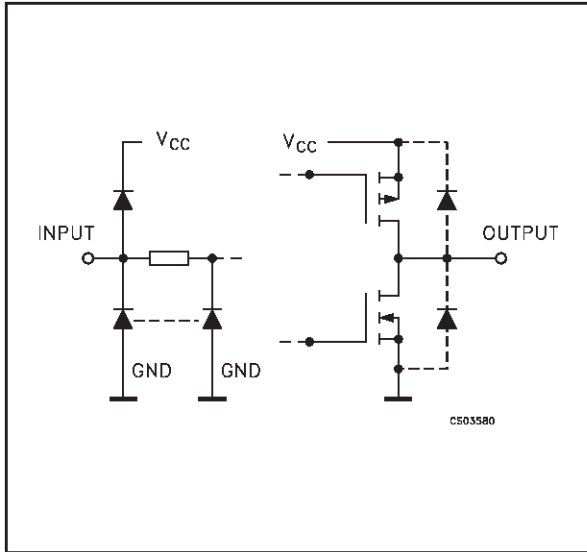
select BA) can multiplex stored and real time (transparent mode) data. The direction control determines which bus will receive data when enable \overline{G} is active (low). In the isolation mode (enable \overline{G} high), "A" data may be stored in one register and/or "B" data may be stored in the other register. When an output function is disabled, the input function is still enabled and may be used to store and transmit data. Only one of the two buses, A or B, may be driven at a time.

All inputs are equipped with protection circuits against static discharge and transient excess voltage.

PIN CONNECTION AND IEC LOGIC SYMBOLS



INPUT AND OUTPUT EQUIVALENT CIRCUIT



PIN DESCRIPTION

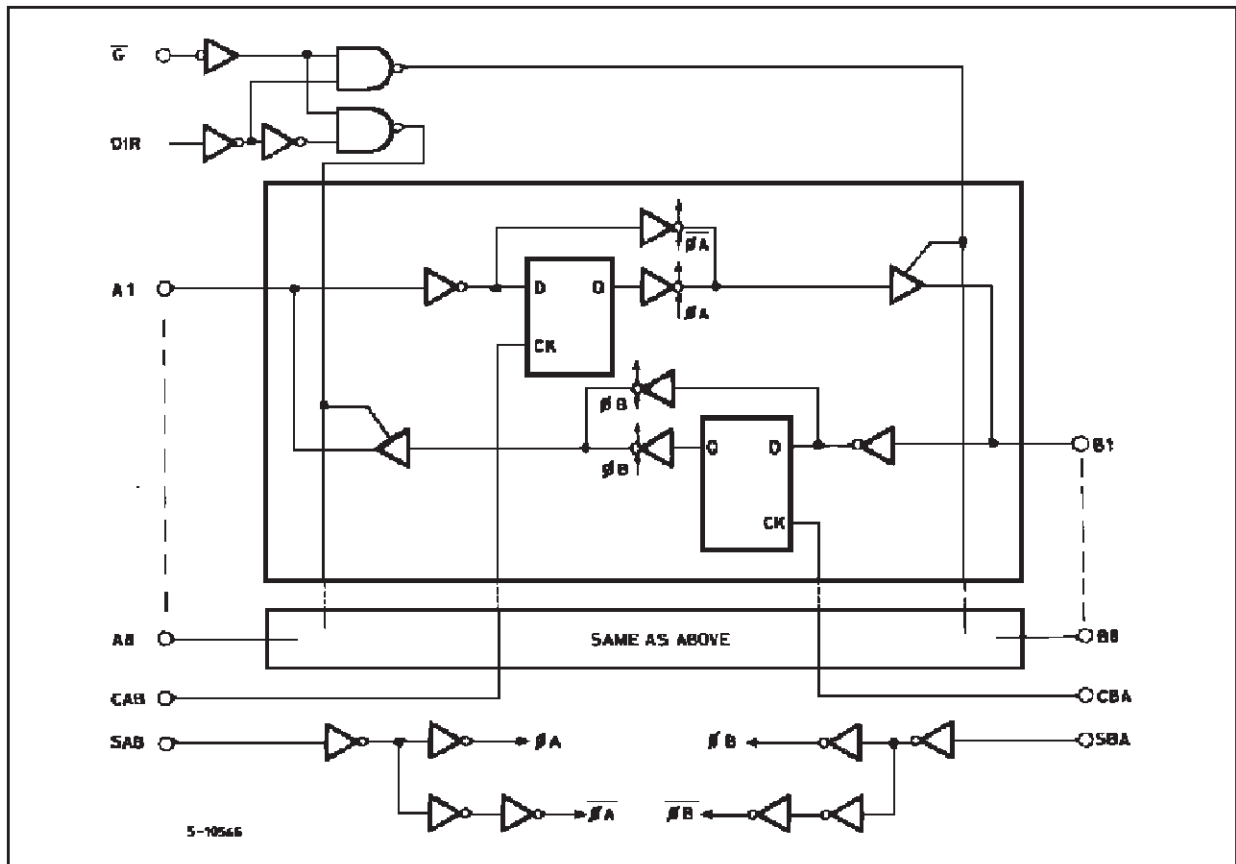
PIN No	SYMBOL	NAME AND FUNCTION
1	CLOCK AB	A to B Clock Input (LOW to HIGH, Edge-Triggered)
2	SELECT AB	Select A to B Source Input
3	GAB	Direction Control Input
4, 5, 6, 7, 8, 9, 10, 11	A1 to A8	A Data Inputs/Outputs
20, 19, 18, 17, 16, 15, 14, 13	B1 to B8	B Data Inputs/Outputs
21	\overline{G}	Output Enable Input (Active LOW)
22	SELECT BA	Select B to A Source Input
23	CLOCK BA	B to A Clock Input (LOW to HIGH, Edge Triggered)
12	GND	Ground (0V)
24	V _{CC}	Positive Supply Voltage

TRUTH TABLE

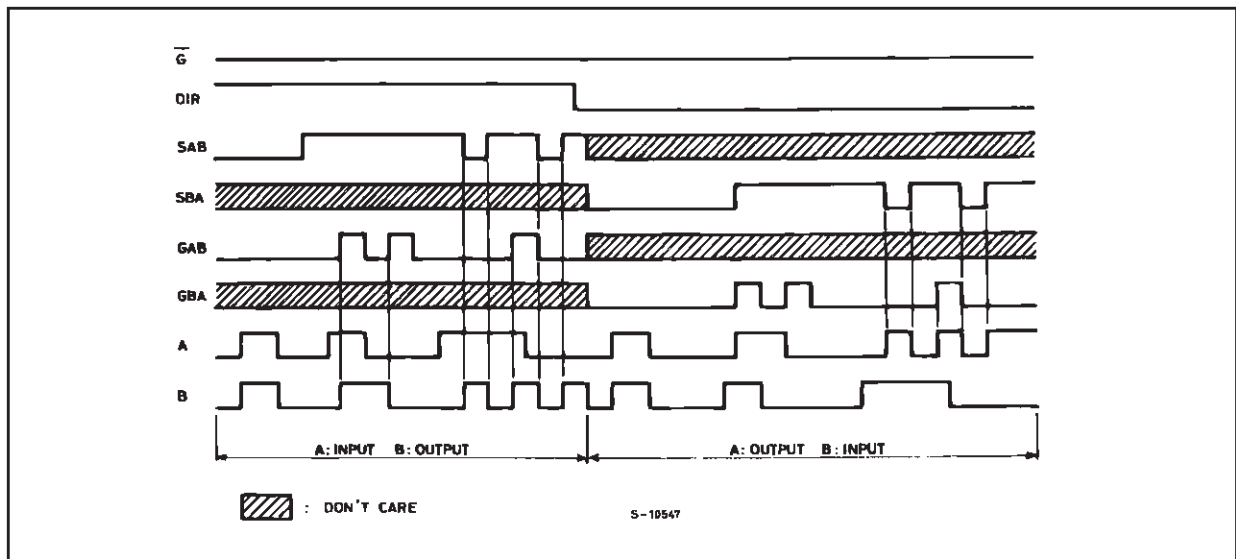
\overline{G}	DIR	CAB	CBA	SAB	SBA	A	B	FUNCTION	
H	X					INPUTS	INPUTS	Both the A bus and the B bus are inputs	
		X	X	X	X	Z	Z	The Output functions of the A and B bus are disabled	
				X	X	INPUTS	INPUTS	Both the A and B bus are used for inputs to the internal flip-flops. Data at the bus will be stored on low to high transition of the clock inputs.	
L	H					INPUTS	OUTPUTS	The A bus are inputs and the B bus are outputs	
		X	X*	L	X	L	L	The data at the A bus are displayed at the B bus	
						H	H		
			X*	L	X	L	L	The data at the A bus are displayed at the B bus. The data of the A bus are stored to internal flip-flop on low to high transition of the clock pulse	
						H	H	The data of the A bus are stored to internal flip-flop on low to high transition of the clock pulse	
X	X*	H	X	X	Qn	Qn	The data stored to the internal flip-flop are displayed at the B bus.		
	X*	H	X	L	L	L	The data at the A bus are stored to the internal flip-flop on low to high transition of the clock pulse. The states of the internal flip-flops output directly to the B bus.		
				H	H	H			
L	L					OUTPUTS	INPUTS	The B bus are inputs and the A bus are outputs.	
		X*	X	X	L	L	L	The data at the B bus are displayed at the A bus	
						H	H		
			X	X	L	L	L	L	The data at the B bus are displayed at the A bus. The data of the B bus are stored to the internal flip-flop on low to high transition of the clock pulse.
						H	H	H	The data of the B bus are stored to the internal flip-flop on low to high transition of the clock pulse
X*	X	X	H	Qn	Qn	Qn	The data stored to the internal flip-flops are displayed at the A bus		
	X	X	H	L	L	L	The data at the B bus are stored to the internal flip-flop on low to high transition of the clock pulse. The states of the internal flip-flops output directly to the A bus.		
				H	H	H			

X : Don't Care
 Z : High Impedance
 Qn : The data stored to the internal flip-flops by most recent low to high transition of the clock inputs
 * : The data at the A and B bus will be stored to the internal flip-flops on every low to high transition of the clock inputs.

LOGIC DIAGRAM



TIMING CHART



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	-0.5 to +7	V
V_I	DC Input Voltage	-0.5 to $V_{CC} + 0.5$	V
V_O	DC Output Voltage	-0.5 to $V_{CC} + 0.5$	V
I_{IK}	DC Input Diode Current	± 20	mA
I_{OK}	DC Output Diode Current	± 20	mA
I_O	DC Output Current	± 35	mA
I_{CC} or I_{GND}	DC V_{CC} or Ground Current	± 70	mA
P_D	Power Dissipation	500(*)	mW
T_{stg}	Storage Temperature	-65 to +150	°C
T_L	Lead Temperature (10 sec)	300	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied

(*) 500mW at 65 °C; derate to 300mW by 10mW/°C from 65°C to 85°C

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	4.5 to 5.5	V
V_I	Input Voltage	0 to V_{CC}	V
V_O	Output Voltage	0 to V_{CC}	V
T_{op}	Operating Temperature	-55 to 125	°C
t_r, t_f	Input Rise and Fall Time ($V_{CC} = 4.5$ to $5.5V$)	0 to 500	ns

DC SPECIFICATIONS

Symbol	Parameter	Test Condition		Value						Unit	
		V _{CC} (V)		T _A = 25°C			-40 to 85°C		-55 to 125°C		
				Min.	Typ.	Max.	Min.	Max.	Min.		Max.
V _{IH}	High Level Input Voltage	4.5 to 5.5		2.0			2.0		2.0		V
V _{IL}	Low Level Input Voltage	4.5 to 5.5				0.8		0.8		0.8	V
V _{OH}	High Level Output Voltage	4.5	I _O = -20 μA	4.4	4.5		4.4		4.4		V
			I _O = -6.0 mA	4.18	4.31		4.13		4.10		
V _{OL}	Low Level Output Voltage	4.5	I _O = 20 μA		0.0	0.1		0.1		0.1	V
			I _O = 6.0 mA		0.17	0.26		0.33		0.40	
I _I	Input Leakage Current	5.5	V _I = V _{CC} or GND			± 0.1		± 1		± 1	μA
I _{OZ}	High Impedance Output Leakage Current	5.5	V _I = V _{IH} or V _{IL} V _O = V _{CC} or GND			± 0.5		± 5		± 10	μA
I _{CC}	Quiescent Supply Current	5.5	V _I = V _{CC} or GND			4		40		80	μA
Δ I _{CC}	Additional Worst Case Supply Current	5.5	Per Input pin V _I = 0.5V or V _I = 2.4V Other Inputs at V _{CC} or GND I _O = 0			2.0		2.9		3.0	mA

M74HCT646

AC ELECTRICAL CHARACTERISTICS ($C_L = 50$ pF, Input $t_r = t_f = 6$ ns)

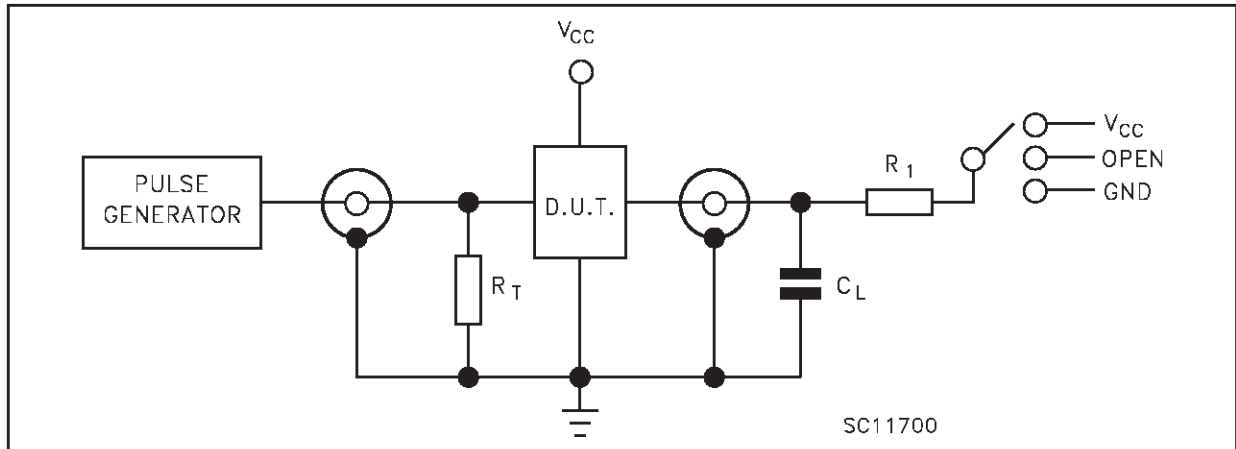
Symbol	Parameter	Test Condition			Value						Unit	
		V_{CC} (V)	C_L (pF)		$T_A = 25^\circ\text{C}$			-40 to 85°C		-55 to 125°C		
					Min.	Typ.	Max.	Min.	Max.	Min.		Max.
t_{TLH} t_{THL}	Output Transition Time	4.5	50			7	12		15		19	ns
t_{PLH} t_{PHL}	Propagation Delay Time	4.5	50			20	30		38		48	ns
			150			25	38		48		60	
t_{PLH} t_{PHL}	Propagation Delay Time(CLOCK-A,B)	4.5	50			29	44		55		65	ns
			150			34	52		65		75	
t_{PLH} t_{PHL}	Propagation Delay Time (SELECT - A,B)	4.5	50			24	34		43		53	ns
			150			29	42		53		65	
t_{PZL} t_{PZH}	High Impedance Output Enable Time (G, DIR)	4.5	50	$R_L = 1\text{ K}\Omega$		26	38		48		60	ns
			150	$R_L = 1\text{ K}\Omega$		31	46		58		70	
t_{PLZ} t_{PHZ}	High Impedance Output Disable Time (G, DIR)	4.5	50	$R_L = 1\text{ K}\Omega$		26	35		44		55	ns
f_{MAX}	Maximum Clock Frequency	4.5	50		31	55		25		20		MHz
$t_{W(H)}$ $t_{W(L)}$	Minimum Pulse Width	4.5	50			8		15		19		ns
t_s	Minimum Set-Up Time	4.5	50			3	10		13		13	ns
t_h	Minimum Hold Time	4.5	50				5		5		5	ns

CAPACITIVE CHARACTERISTICS

Symbol	Parameter	Test Condition			Value						Unit	
		V_{CC} (V)			$T_A = 25^\circ\text{C}$			-40 to 85°C		-55 to 125°C		
					Min.	Typ.	Max.	Min.	Max.	Min.		Max.
C_{IN}	Input Capacitance					5	10		10		10	pF
$C_{I/O}$	Bus Terminal Capacitance					13						pF
C_{PD}	Power Dissipation Capacitance (note 1)					40						pF

1) C_{PD} is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit). Average operating current can be obtained by the following equation. $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}/8$ (per bit)

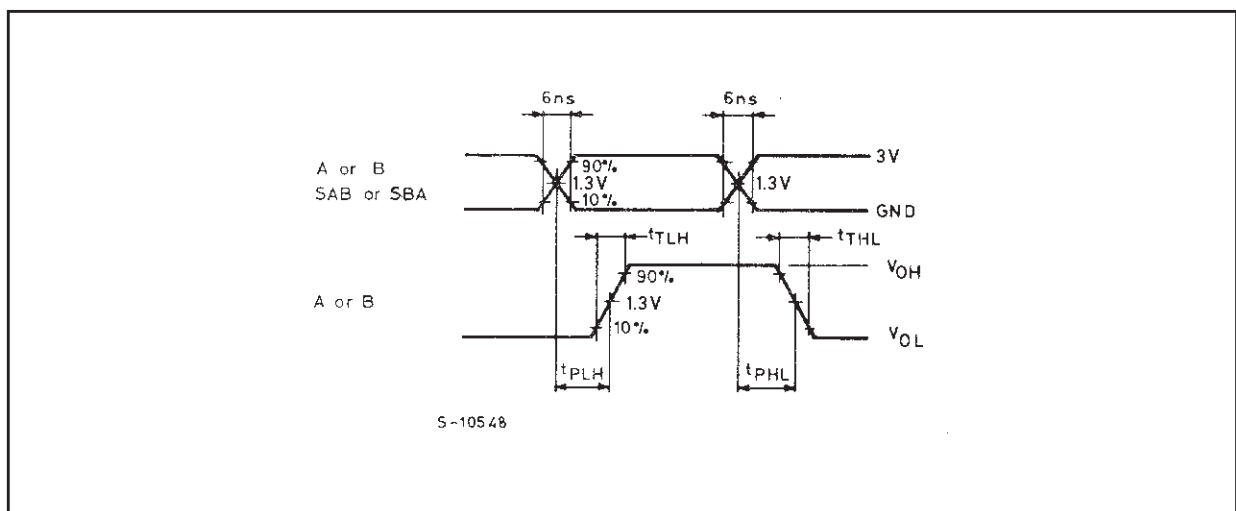
TEST CIRCUIT



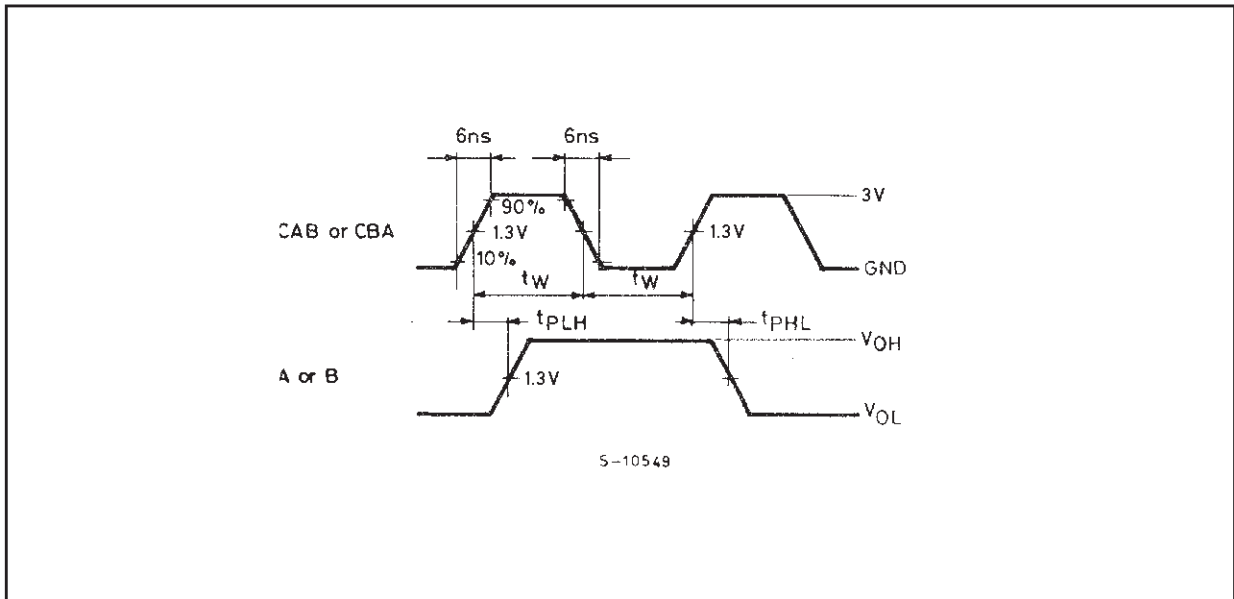
TEST	SWITCH
t_{PLH} , t_{PHL}	Open
t_{PZL} , t_{PLZ}	V_{CC}
t_{PZH} , t_{PHZ}	GND

C_L = 50pF/150pF or equivalent (includes jig and probe capacitance)
 R_1 = 1K Ω or equivalent
 R_T = Z_{OUT} of pulse generator (typically 50 Ω)

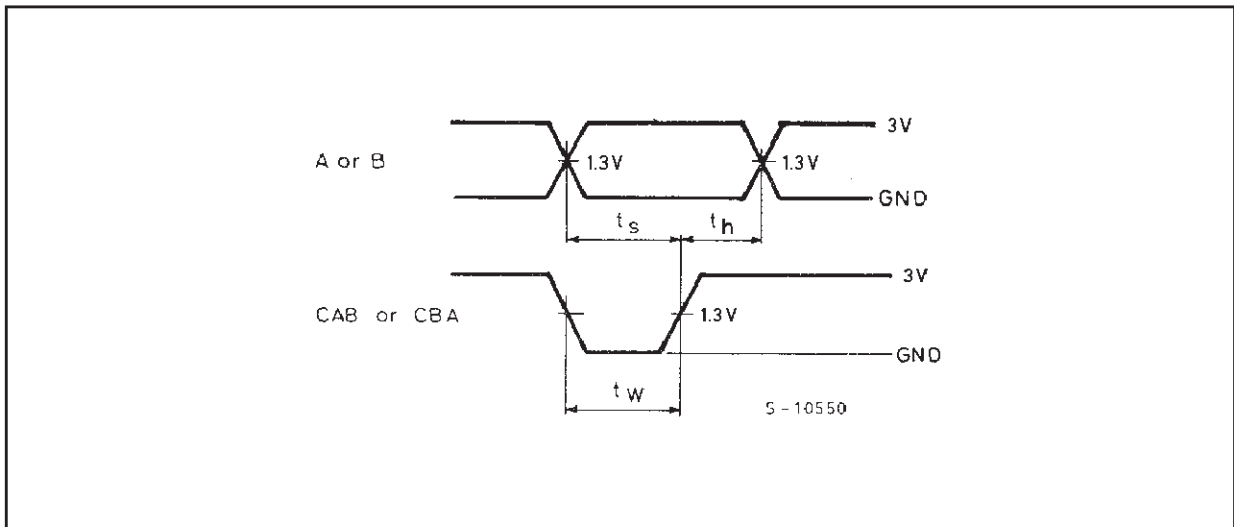
WAVEFORM 1: PROPAGATION DELAY TIME (f=1MHz; 50% duty cycle)



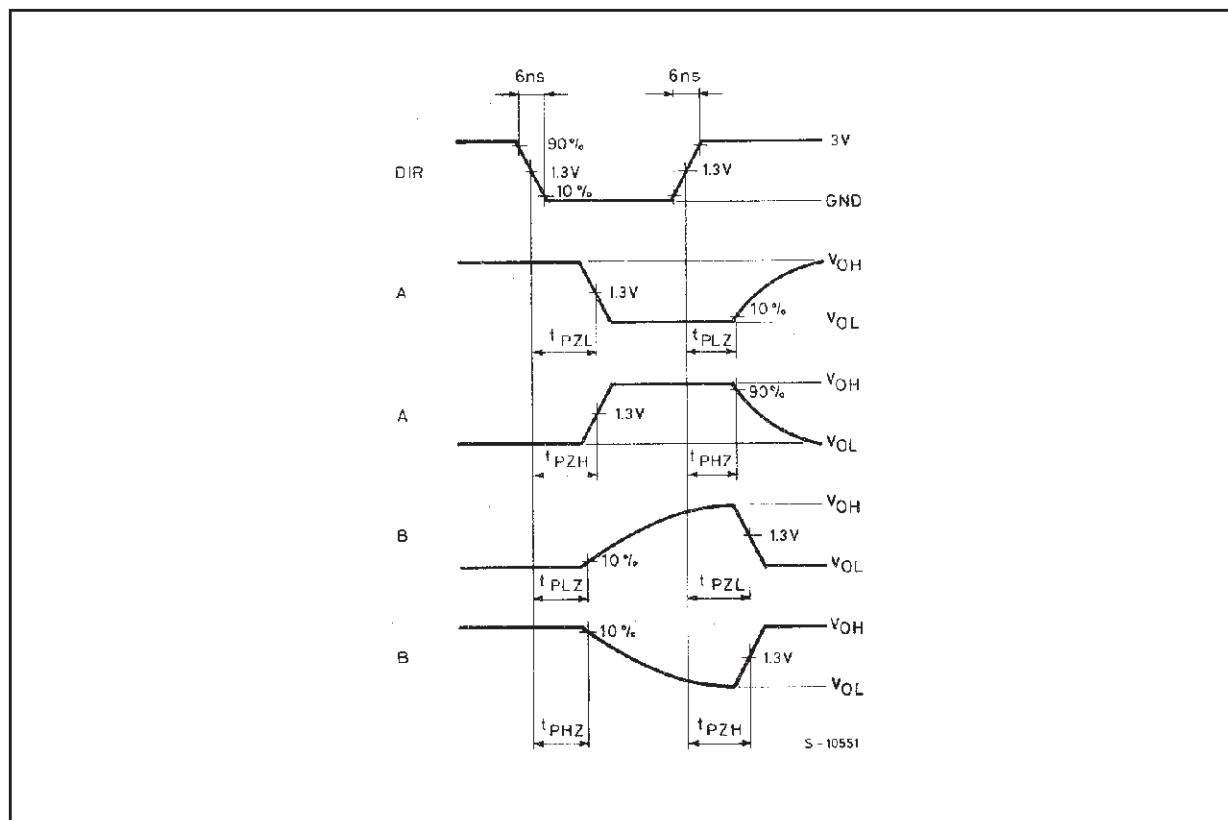
WAVEFORM 2 : CLOCK AB, BA MINIMUM PULSE WIDTH, PROPAGATION DELAY TIME (f=1MHz; 50% duty cycle)



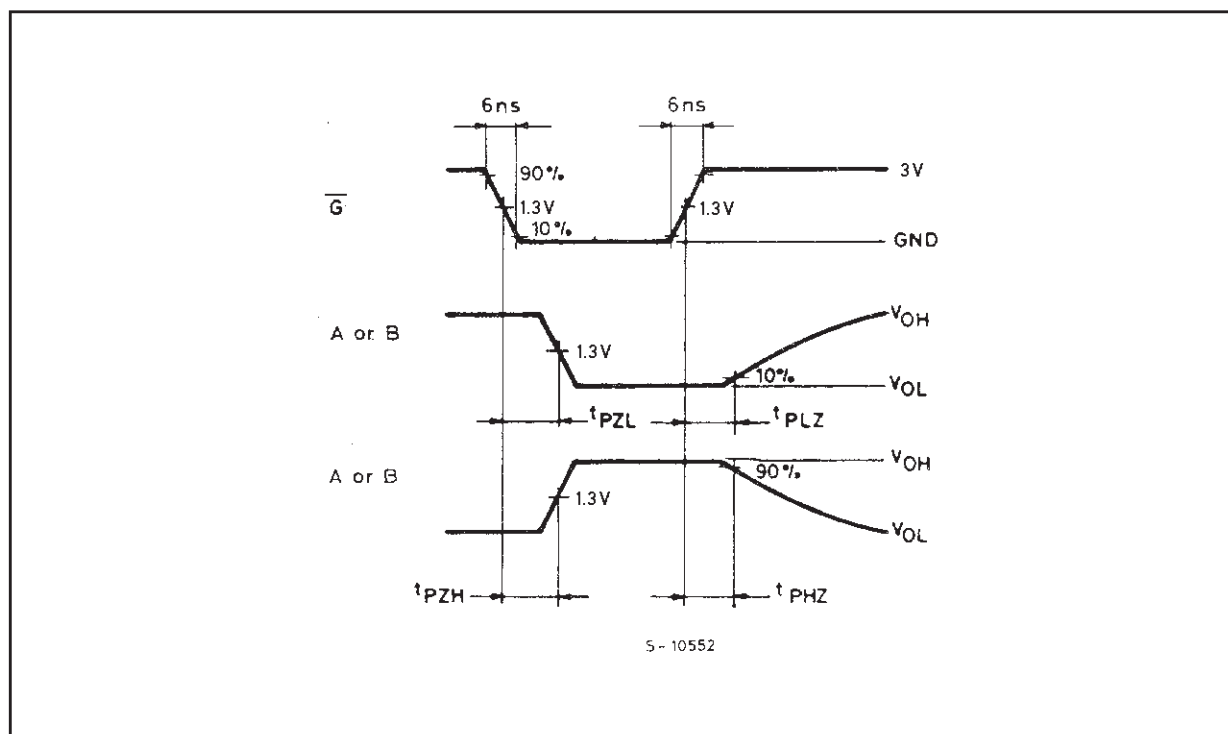
WAVEFORM 3: A, B TO CLOCK MINIMUM SETUP AND HOLD TIME (f=1MHz; 50% duty cycle)



WAVEFORM 4 : OUTPUT ENABLE AND DISABLE TIME (f=1MHz; 50% duty cycle)

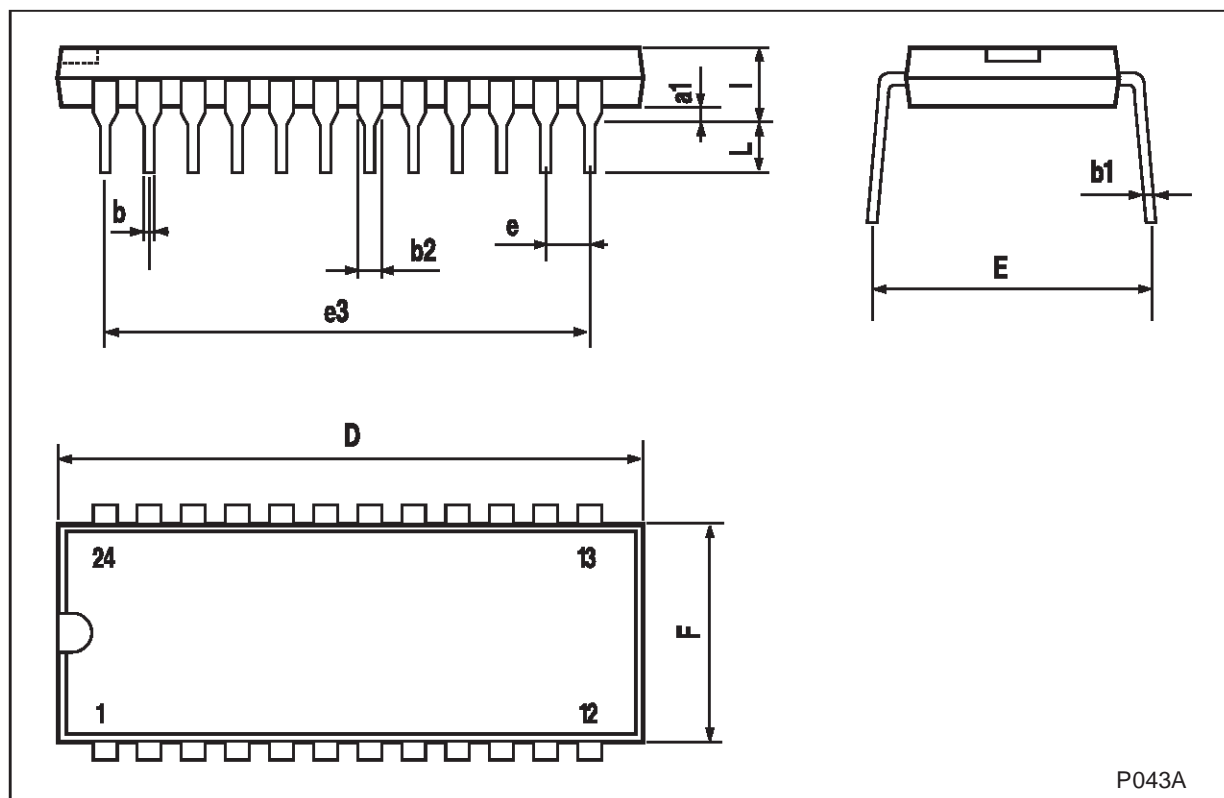


WAVEFORM 5: OUTPUT ENABLE AND DISABLE TIME (f=1MHz; 50% duty cycle)



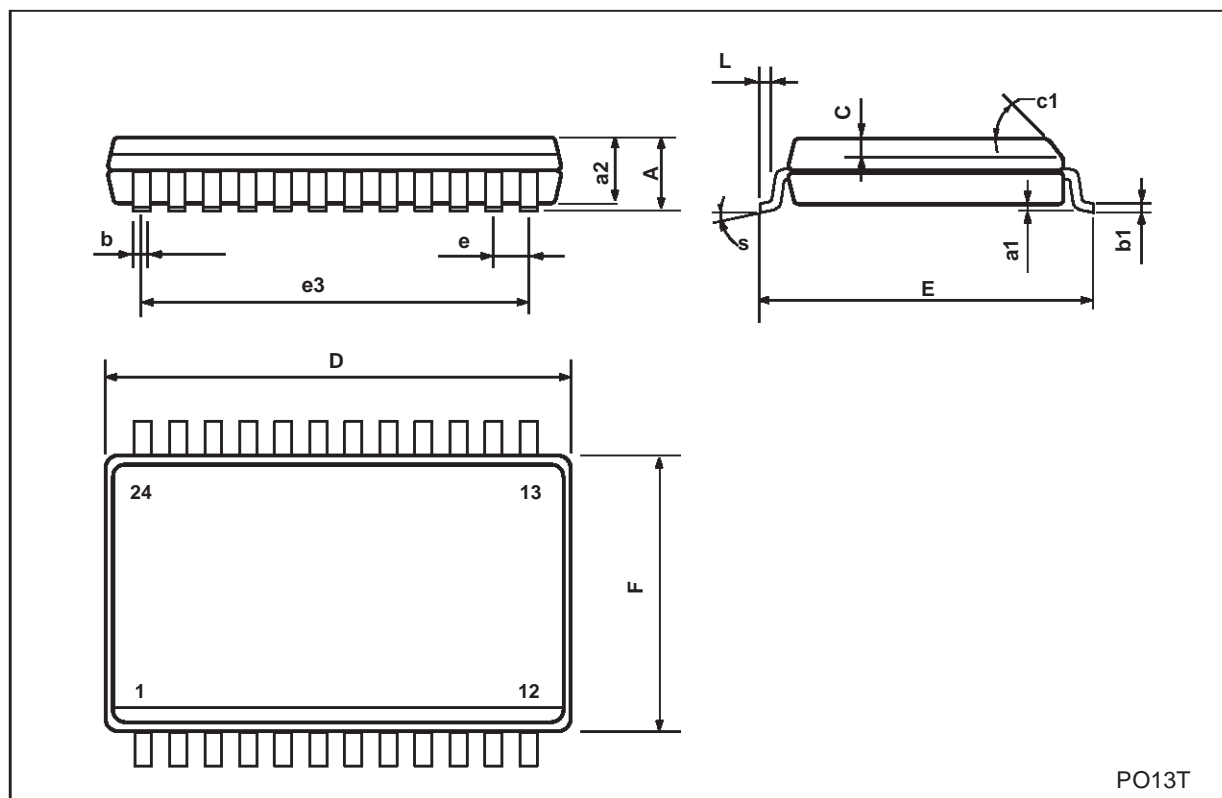
Plastic DIP-24 (0.25) MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
a1		0.63			0.025	
b		0.45			0.018	
b1	0.23		0.31	0.009		0.012
b2		1.27			0.500	
D			32.2			1.268
E	15.2		16.68	0.598		0.657
e		2.54			0.100	
e3		27.94			1.100	
F			14.1			0.555
I		4.445			0.175	
L		3.3			0.130	



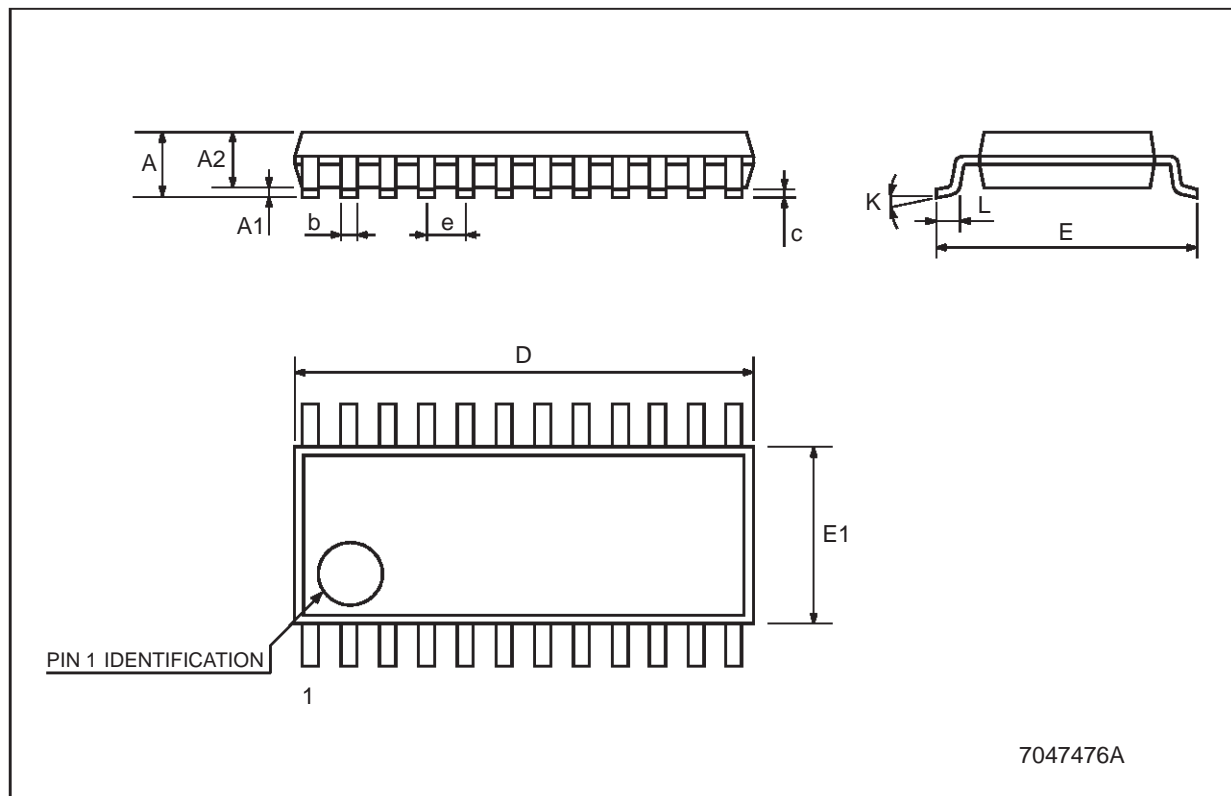
SO-24 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A			2.65			0.104
a1	0.1		0.2	0.004		0.008
a2			2.45			0.096
b	0.35		0.49	0.014		0.019
b1	0.23		0.32	0.009		0.012
C		0.5			0.020	
c1	45° (typ.)					
D	15.20		15.60	0.598		0.614
E	10.00		10.65	0.393		0.419
e		1.27			0.050	
e3		13.97			0.550	
F	7.40		7.60	0.291		0.300
L	0.50		1.27	0.020		0.050
S	8° (max.)					



TSSOP24 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.1			0.043
A1	0.05		0.15	0.002		0.006
A2		0.9			0.035	
b	0.19		0.30	0.0075		0.0118
c	0.09		0.20	0.0035		0.0079
D	7.7		7.9	0.303		0.311
E	6.25		6.5	0.246		0.256
E1	4.3		4.5	0.169		0.177
e		0.65 BSC			0.0256 BSC	
K	0°		8°	0°		8°
L	0.50		0.70	0.020		0.028



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